

20 STERN AVE.
 SPRINGFIELD, NEW JERSEY 07081
 U.S.A.

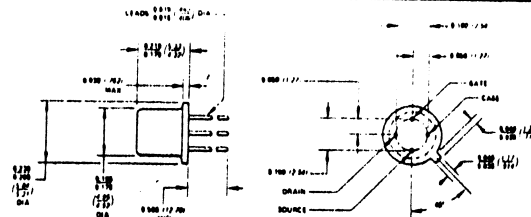
2N4117 2N4119 2N4118
 2N4117A 2N4119A 2N4118A

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N-CHANNEL SILICON JUNCTION FIELD-EFFECT TRANSISTORS

FOR VERY LOW INPUT CURRENT DC AMPLIFIERS

- $I_{GSS} < 1 \text{ pA}$ (2N4117A Series)
- $I_{GSS} < 10 \text{ pA}$ (2N4117 Series)



JEDEC TO-72
 Fourth lead is in electrical contact with case.

PRODUCT CONDITIONING

Units receive the following treatment before final electrical tests:

High Temp Storage: 24 Hours at 150°C 25,000g Acceleration/Impact in the Y1 Plane
 Thermal Shock: +100 to 0°C for 5 Cycles Helium and/or Gross Leak Tests for Hermeticity

***ABSOLUTE MAXIMUM RATINGS (25°C)**

Gate-Drain or Gate-Source Voltage (Note 1)	-40 V
Gate-Current	50 mA
Total Device Dissipation (Derate 2 mW/°C to 175°C)	300 mW
Storage Temperature Range	-65 to +175°C
Lead Temperature 1/16" from Case for 10 sec	255°C

***ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)**

Characteristic	Test Conditions	2N4117 2N4117A		2N4118 2N4118A		2N4119 2N4119A		Unit
		Min	Max	Min	Max	Min	Max	
I_{GSS} Gate Reverse Current 2N4117 Series Only	$V_{GS} = -20 \text{ V}$, $V_{DS} = 0$	25°C	-10		-10		-10	pA
		150°C	-25		-25		-25	nA
I_{GSS} Gate Reverse Current 2N4117A Series Only	$V_{GS} = -20 \text{ V}$, $V_{DS} = 0$	25°C	-1		-1		-1	pA
		150°C	-2.5		-2.5		-2.5	nA
BV_{GSS} Gate-Source Breakdown Voltage	$I_G = -1 \mu\text{A}$, $V_{DS} = 0$	-40		-40		-40		V
V_p Gate-Source Pinch-Off Voltage	$V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ nA}$	-0.6	-1.8	-1	-3	-2	-6	V
I_{DSS} Drain Current at Zero Gate Voltage (Note 2)	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0$	0.03	0.09	0.08	0.24	0.20	0.60	mA
g_{fs} Common-Source Forward Transconductance (Note 2)	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0$, $f = 1 \text{ kHz}$	70	210	80	250	100	330	μmho
g_{oss} Common-Source Output Conductance	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0$, $f = 1 \text{ kHz}$		3		5		10	μmho
C_{iss} Common-Source Input Capacitance	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0$, $f = 1 \text{ MHz}$		3		3		3	pF
C_{rss} Common-Source Reverse Transfer Capacitance	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0$, $f = 1 \text{ MHz}$		1.5		1.5		1.5	pF

NOTES:

1. Due to symmetrical geometry, these units may be operated with source and drain leads interchanged.
 2. This parameter is measured during a 2 ms interval 100 ms after power is applied. (Not a JEDEC condition.)
- *JEDEC registered data.



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